FORM #10-1940 (PGV. 7080)	703	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE								ATTY. DOCKET NO.: 976.1001US		SERIAL NO.: 09/808,067			
0 20	LIST OF PRIOR ART CITED BY APPLICANT (US everal sheets if necessary)									APPLICANT(S): Stephen L. ABBOTT, et al.					
Alman	Autrant & The								FILING DATE: March 14, 2001 GROUP: 2122						
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*EXAMINER INITIAL		DOCUMENT NUMBER DATE								NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
A)	AA	5	6	3	0	0	7	0	05/13/1997	Dietrich, et al.	395	208			
	AB_	5	9	1	8	0	5	1	05/29/1999	Savitzky, et al.	395	683			
1/8	AC	5	9	7	1	5	8	5	10/26/1999	Dangat, et al.	364	468.08			
	AD	6	0	6	1	7	5	0	05/09/2000	Beardsley, et al.	710	74	CEI	VED	
Ma	AE	6	0	8	5	4	9	3	07/11/2000	DeBusk, et al.	53	445	OLI	V	
	AF	6	1	4	1	7	0	8	10/31/2000	Tavallaei, et al.	710	62 F	EB 04	2004	
0	AG	6	1	5	9	4	1_	1	12/12/2000	Kulkami, et al.	264	401 Techno	lloav Ce	nter 210	
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12	AK	Tang, Y., et al., "INTEGRATED APPROACH TO DISASSEMBLY PLANNING AND DEMANUFACTURING OPERATION," IEEE International Symposium on Electronics and the Environment, San Francisco, May 8-10, 2000, Processings of ISEE 2000, pp. 354-359													
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